


<b>Search Notes</b> 	<b>Application/Control No.</b> 10551168	<b>Applicant(s)/Patent Under Reexamination</b> CHUNG ET AL.
	<b>Examiner</b> Mark Kopec	<b>Art Unit</b> 1796

SEARCHED			
Class	Subclass	Date	Examiner
252	519.2, 519.21, 520.3	04/21/09	M.K.
423	23, 604	"	"
556	110	"	"

SEARCH NOTES		
Search Notes	Date	Examiner
PALM inventor name search	04/21/09	M.K.
EAST	"	"
Reviewed 210 Search Report	"	"

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/M. K./ Primary Examiner.Art Unit 1796
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